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8-9-02

**NOTICE OF APPEAL FROM THE PRIMARY EXAMINER TO
THE BOARD OF PATENT APPEALS AND INTERFERENCES (Large Entity)**

Docket No.
35236-00001

In Re Application Of:

DANIEL LOPEZ et al.

Serial No. 397349,728	Filing Date February 13, 1999	Examiner M. Dastouri	Group Art Unit 2623
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Invention:

Reticle Defect Detection Using Simulation

JUL 31 2002

PATENT & TRADEMARK OFFICE

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Technology Center 2600

TO THE ASSISTANT COMMISSIONER FOR PATENTS:

Applicants hereby appeals to the Board of Patent Appeals and Interferences from the decision of the Primary Examiner dated March 25, 2002, finally rejecting claims.

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ORIGINALLY FILED**

The fee for the Notice of Appeal is: \$320.00

- A check in the amount of the fee is enclosed.
- The Commissioner has already been authorized to charge fees in this application to a Deposit Account. A duplicate copy of this sheet is enclosed.
- The Commissioner is hereby authorized to charge any additional fees which may be required, or credit any overpayment to Deposit Account No. 13-3735.
A duplicate copy of this sheet is enclosed.



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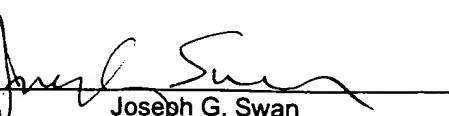
Dated: July 25, 2002

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320.00 OP

Certificate Under 37 C.F.R. 1.8
I hereby certify that on July 25, 2002, the date that I am signing this certificate, this correspondence and any attachments are being deposited with the United States Postal Service, First Class Mail, postage pre-paid, in an envelope addressed to the Assistant Commissioner for Patents, Washington, D.C. 20231



Joseph G. Swan